

Product Summary

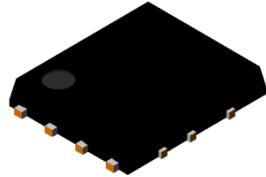
Device	BV_{DSS}	$R_{DS(ON)}$	I_D $T_C = +25^\circ C$
Q1	30V	11.1mΩ @ $V_{GS} = 10V$	35A
		14.0mΩ @ $V_{GS} = 4.5V$	27A
Q2	30V	6.0mΩ @ $V_{GS} = 10V$	50A
		10.0mΩ @ $V_{GS} = 4.5V$	35A

Description and Applications

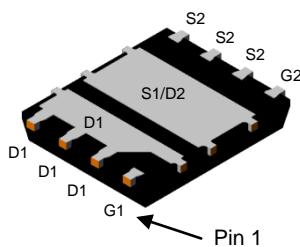
This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Notebook Battery Power Management
- DC-DC Converters
- Loadswitch

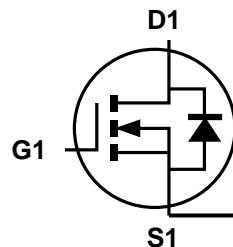
PowerDI5060-8 (Type S)



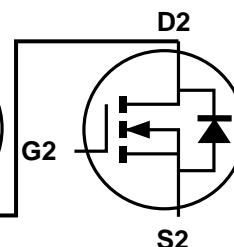
Top View



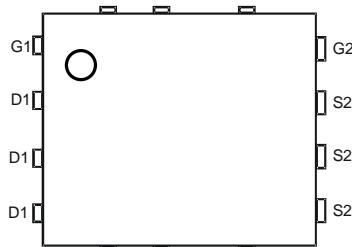
Bottom View



Q1 N-Channel MOSFET



Q2 N-Channel MOSFET



Top View
Pin Configuration

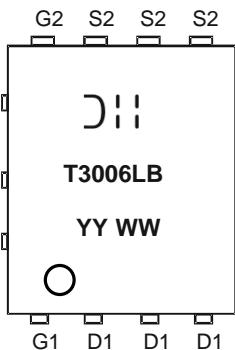
Ordering Information (Note 4)

Part Number	Case	Packaging
DMT3006LPB-13	PowerDI5060-8 (Type S)	2500 / Tape & Reel

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
2. See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.

Marking Information



DII = Manufacturer's Marking
T3006LB = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 18 = 2018)
WW = Week (01 to 53)

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic			Symbol	Q1 Value	Q2 Value	Unit
Drain-Source Voltage			V_{DSS}	30	30	V
Gate-Source Voltage			V_{GSS}	± 20	± 20	V
Continuous Drain Current (Note 7) $V_{GS} = 10\text{V}$	Steady State	$T_C = +25^\circ\text{C}$ $T_C = +70^\circ\text{C}$	I_D	35 27	50 40	A
Continuous Drain Current (Note 6) $V_{GS} = 10\text{V}$	Steady State	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_D	11 9	14 11	A
Maximum Body Diode Forward Current (Note 7)			I_S	40	50	A
Pulsed Drain Current (10 μs Pulse, Duty Cycle = 1%)			I_{DM}	80	100	A
Pulsed Body Diode Forward Current (10 μs Pulse, Duty Cycle = 1%)			I_{SM}	80	100	A
Avalanche Current (Note 8) $L = 0.1\text{mH}$			I_{AS}	19	23	A
Avalanche Energy (Note 8) $L = 0.1\text{mH}$			E_{AS}	18	28	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P_D	1.1	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	116	$^\circ\text{C}/\text{W}$
Total Power Dissipation (Note 6)	P_D	1.7	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	72	$^\circ\text{C}/\text{W}$
Total Power Dissipation (Note 7)	P_D	30	W
Thermal Resistance, Junction to Case (Note 7)	$R_{\theta JC}$	4	$^\circ\text{C}/\text{W}$
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Electrical Characteristics Q1 N-Channel (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BV_{DSS}	30	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	1	μA	$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$V_{GS} = 20\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = -16\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	$V_{GS(TH)}$	1.0	—	3.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	6.7	11.1	$\text{m}\Omega$	$V_{GS} = 10\text{V}, I_D = 11.5\text{A}$
		—	11.0	14.0		$V_{GS} = 4.5\text{V}, I_D = 7\text{A}$
Diode Forward Voltage	V_{SD}	—	0.8	1.2	V	$V_{GS} = 0\text{V}, I_S = 10\text{A}$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	C_{iss}	—	841	—	pF	$V_{DS} = 15\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	349	—		
Reverse Transfer Capacitance	C_{rss}	—	51	—		
Gate Resistance	R_G	—	1.2	—	Ω	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Total Gate Charge ($V_{GS} = 10\text{V}$)	Q_G	—	12.6	—		
Total Gate Charge ($V_{GS} = 4.5\text{V}$)	Q_G	—	6.3	—		
Gate-Source Charge	Q_{GS}	—	1.7	—	nC	$V_{DS} = 15\text{V}, I_D = 14.4\text{A}$
Gate-Drain Charge	Q_{GD}	—	3.1	—		
Turn-On Delay Time	$t_{D(ON)}$	—	4.6	—		
Turn-On Rise Time	t_R	—	3.3	—	ns	$V_{GS} = 10\text{V}, V_{DD} = 15\text{V}, R_G = 1\Omega, I_D = 10\text{A}$
Turn-Off Delay Time	$t_{D(OFF)}$	—	10.2	—		
Turn-Off Fall Time	t_F	—	1.8	—		
Body Diode Reverse Recovery Time	t_{RR}	—	15.6	—	ns	$I_F = 10\text{A}, di/dt = 100\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	Q_{RR}	—	5.8	—	nC	$I_F = 10\text{A}, di/dt = 100\text{A}/\mu\text{s}$

Notes:

5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
7. Thermal resistance from junction to soldering point (on the exposed drain pad).
8. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep $T_J = +25^\circ\text{C}$.
9. Short duration pulse test used to minimize self-heating effect.
10. Guaranteed by design. Not subject to product testing.

Electrical Characteristics Q2 N-Channel (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	—	—	V	V _{GS} = 0V, I _D = 250μA
Zero Gate Voltage Drain Current	I _{DSS}	—	—	1	μA	V _{DS} = 24V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	—	—	±100	nA	V _{GS} = +20V, V _{DS} = 0V V _{GS} = -16V, V _{DS} = 0V
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	V _{GS(TH)}	1.0	—	3.0	V	V _{DS} = V _{GS} , I _D = 250μA
Static Drain-Source On-Resistance	R _{D(on)}	—	5.0	6.0	mΩ	V _{GS} = 10V, I _D = 20A
		—	7.5	10.0		V _{GS} = 4.5V, I _D = 10A
Diode Forward Voltage	V _{SD}	—	0.7	1.2	V	V _{GS} = 0V, I _S = 2A
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	C _{iss}	—	1,155	—	pF	V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	C _{oss}	—	456	—		
Reverse Transfer Capacitance	C _{rss}	—	72	—		
Gate Resistance	R _G	—	2.1	—	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 10V)	Q _G	—	16.7	—	nC	V _{DD} = 15V, I _D = 9A
Total Gate Charge (V _{GS} = 4.5V)	Q _G	—	8.4	—		
Gate-Source Charge	Q _{GS}	—	2.2	—		
Gate-Drain Charge	Q _{GD}	—	3.5	—		
Turn-On Delay Time	t _{D(ON)}	—	3.5	—	ns	V _{DD} = 15V, V _{GS} = 10V, R _G = 3Ω, I _D = 9A
Turn-On Rise Time	t _R	—	5.5	—		
Turn-Off Delay Time	t _{D(OFF)}	—	13.5	—		
Turn-Off Fall Time	t _F	—	4.6	—		
Reverse Recovery Time	t _{RR}	—	19.3	—	ns	I _F = 1.5A, di/dt = 100A/μs
Reverse Recovery Charge	Q _{RR}	—	8.6	—	nC	

Notes: 9. Short duration pulse test used to minimize self-heating effect.

10. Guaranteed by design. Not subject to product testing.

Typical Characteristics - Q1 N-Channel

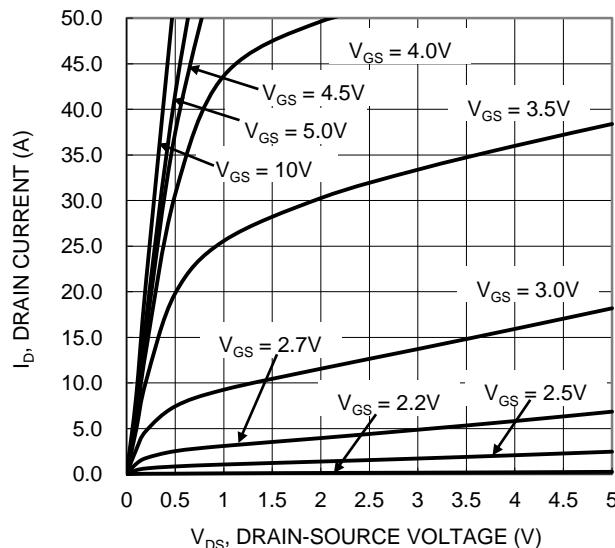


Figure 1. Typical Output Characteristic

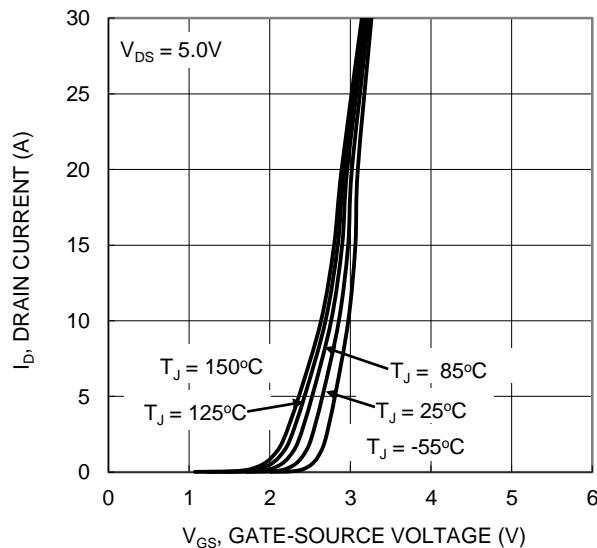


Figure 2. Typical Transfer Characteristic

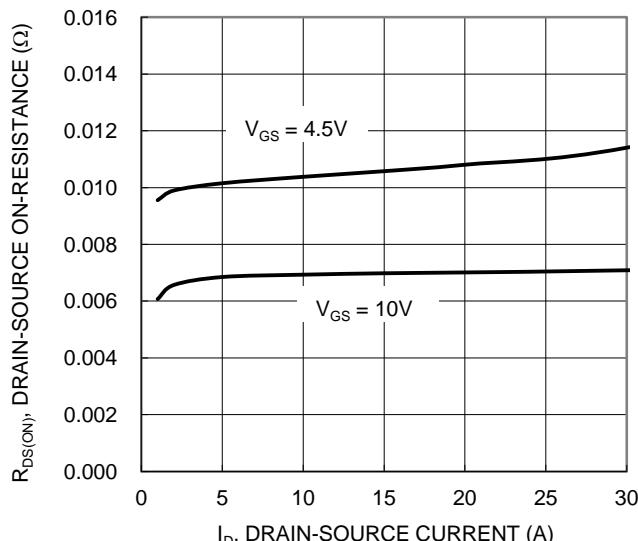


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

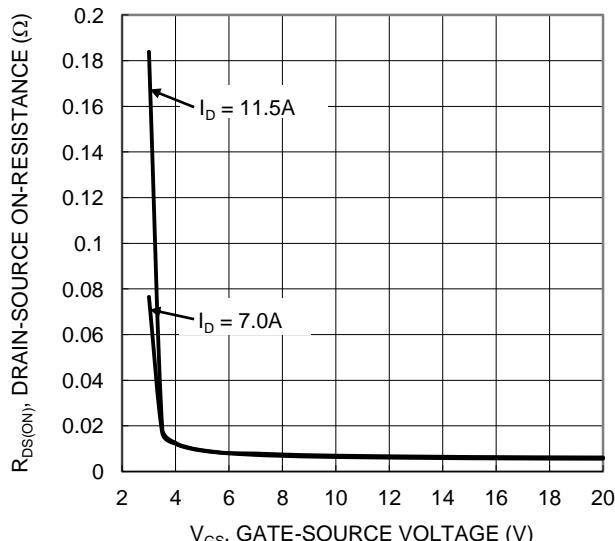


Figure 4. Typical Transfer Characteristic

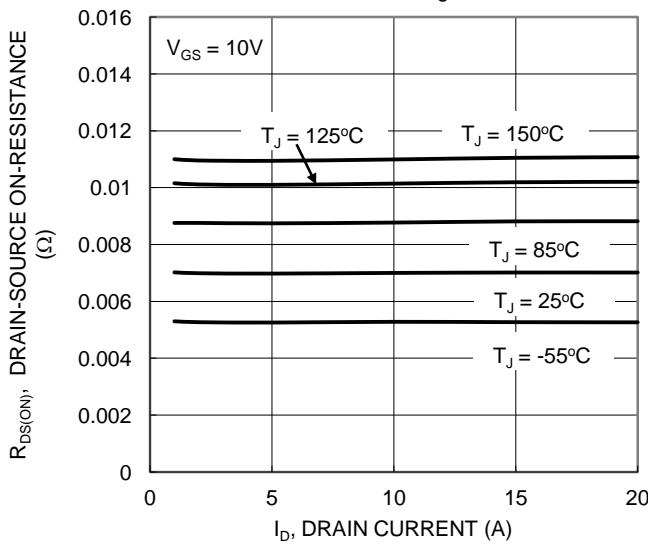


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

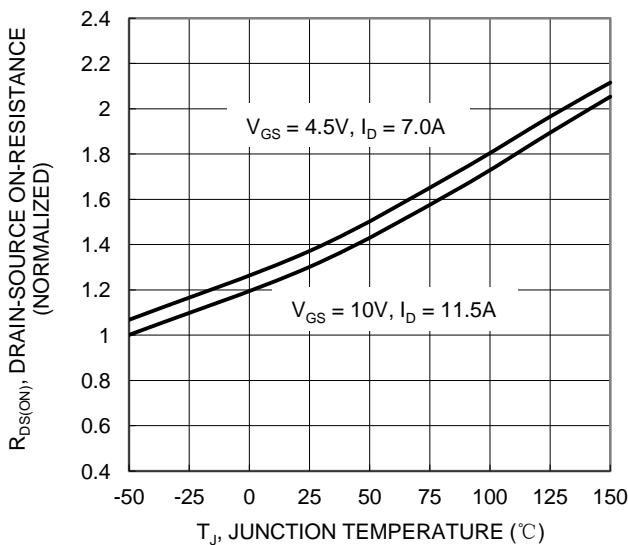


Figure 6. On-Resistance Variation with Temperature

Typical Characteristics - Q1 N-Channel (Cont.)

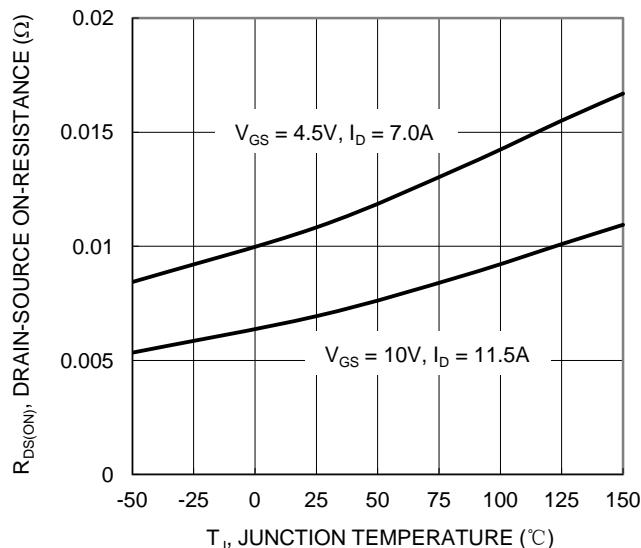


Figure 7. On-Resistance Variation with Temperature

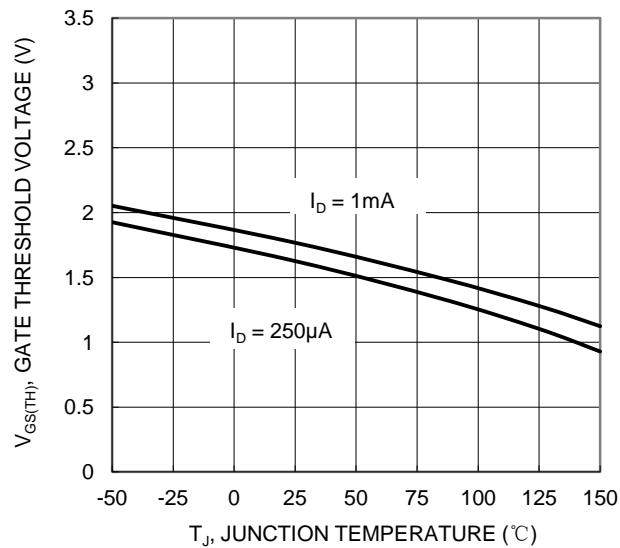


Figure 8. Gate Threshold Variation vs. Junction Temperature

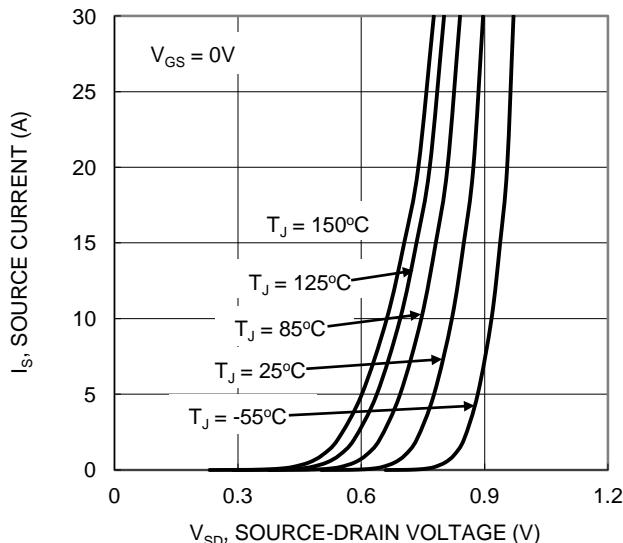


Figure 9. Diode Forward Voltage vs. Current

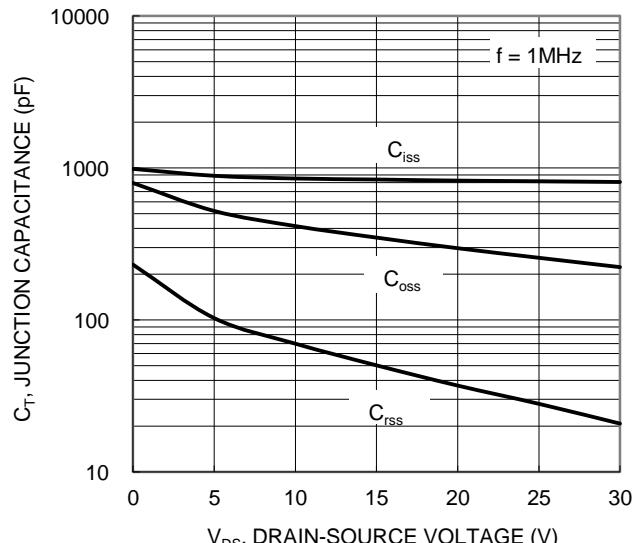


Figure 10. Typical Junction Capacitance

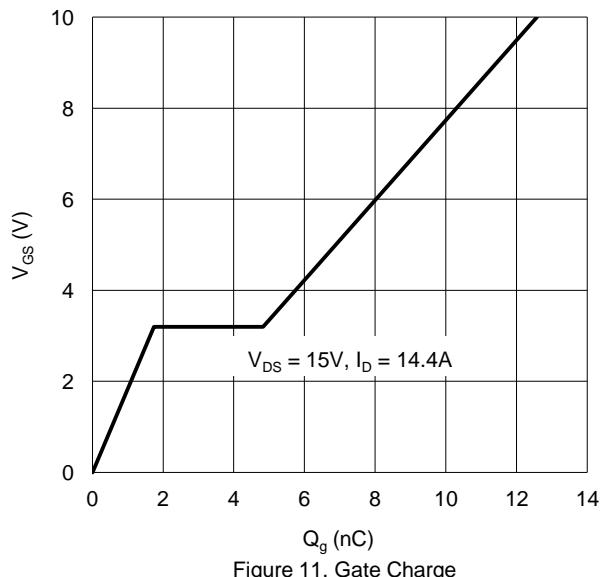


Figure 11. Gate Charge

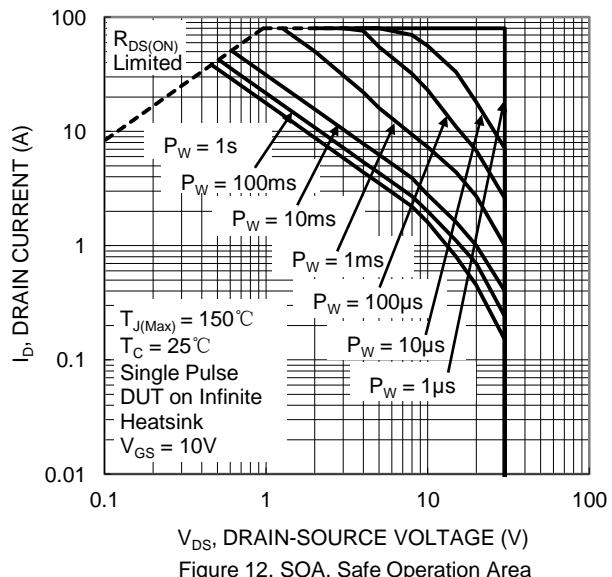


Figure 12. SOA, Safe Operation Area

Typical Characteristics - Q2 N-Channel

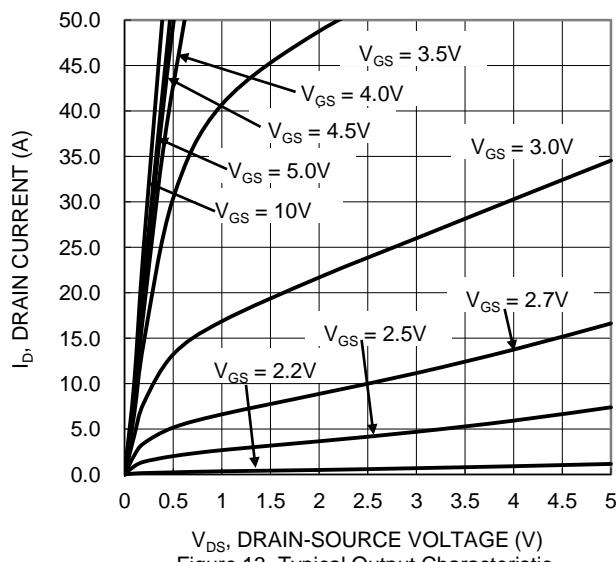


Figure 13. Typical Output Characteristic

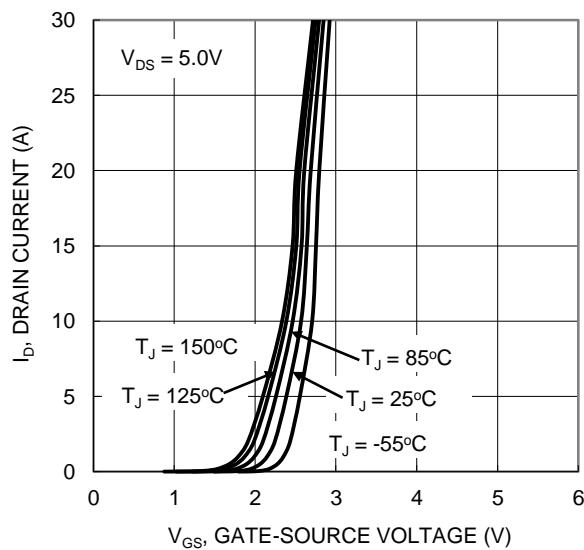


Figure 14. Typical Transfer Characteristic

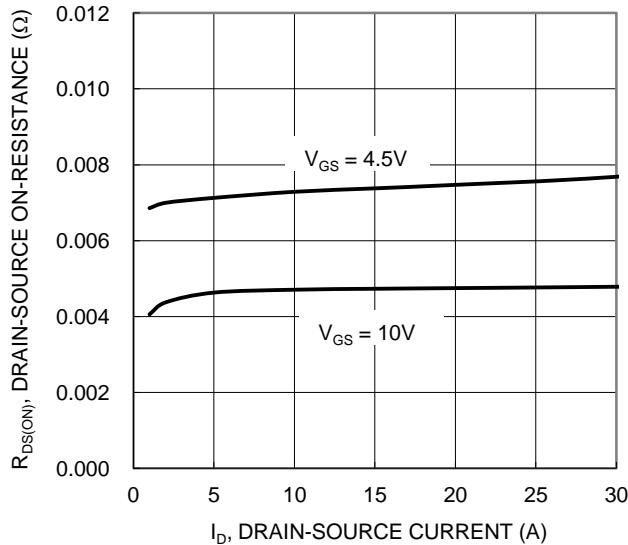


Figure 15. Typical On-Resistance vs. Drain Current and Gate Voltage

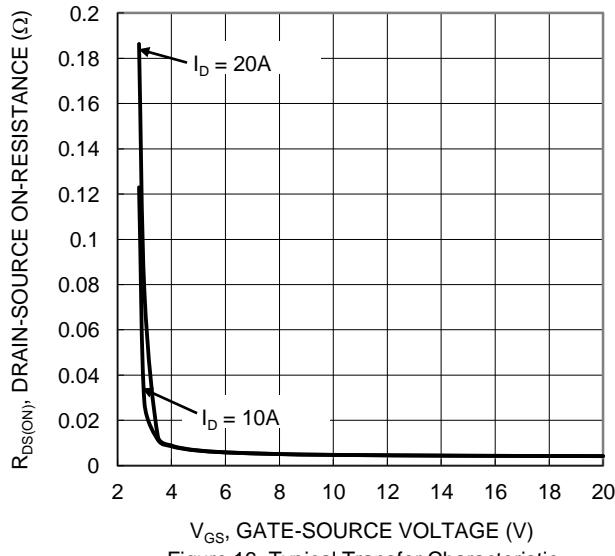


Figure 16. Typical Transfer Characteristic

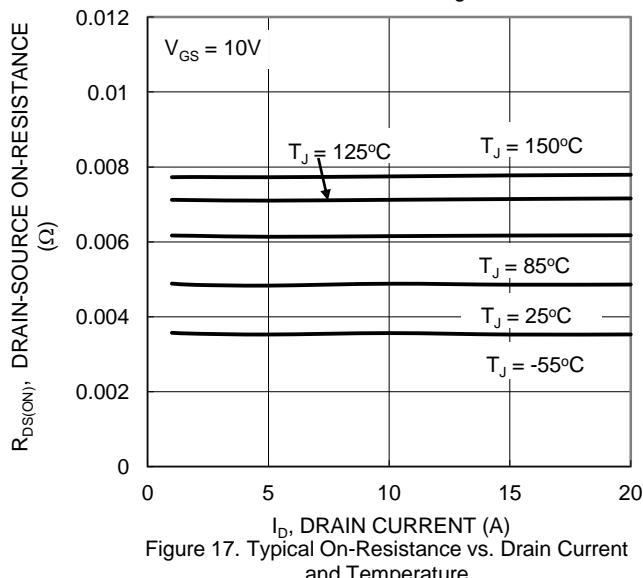


Figure 17. Typical On-Resistance vs. Drain Current and Temperature

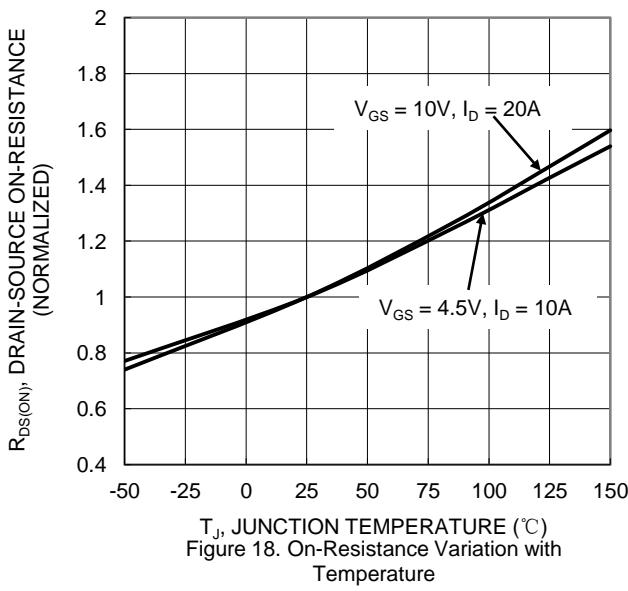
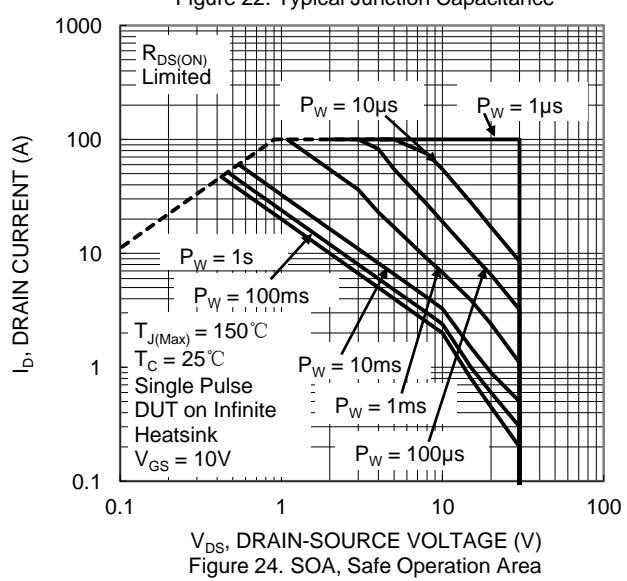
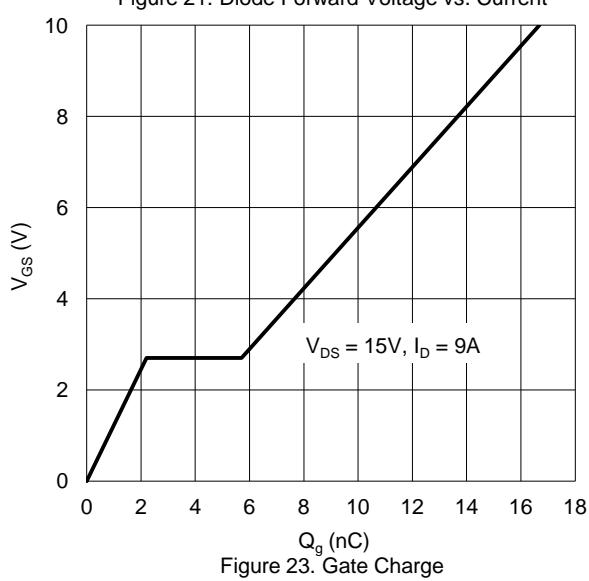
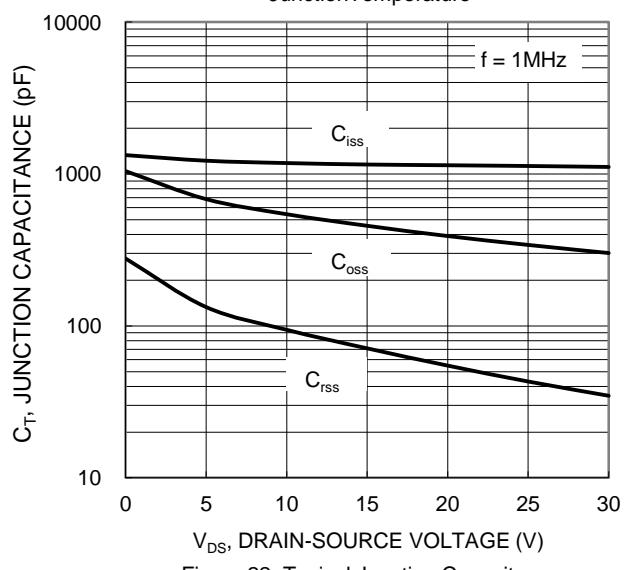
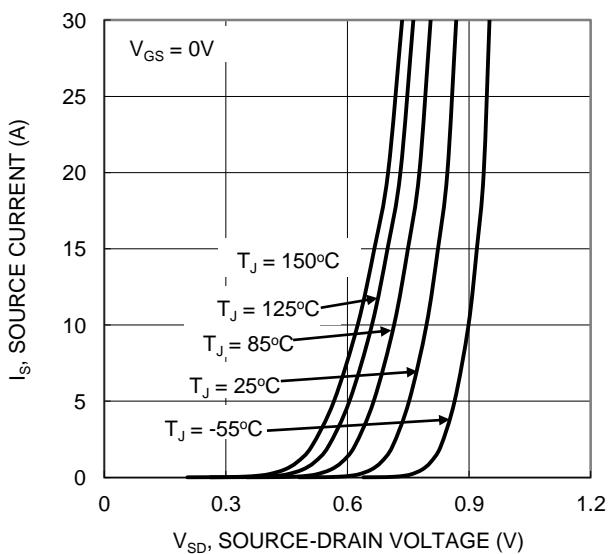
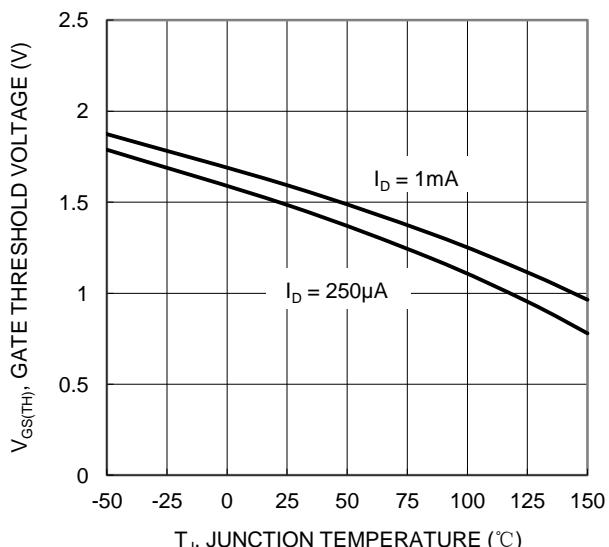
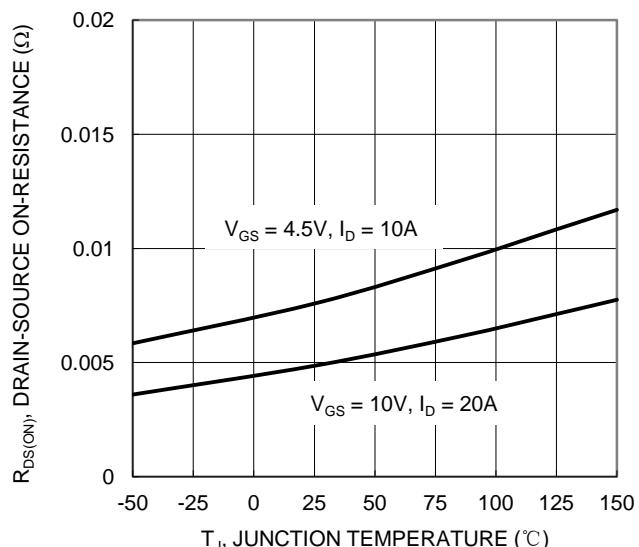


Figure 18. On-Resistance Variation with Temperature

Typical Characteristics - Q2 N-Channel (Cont.)



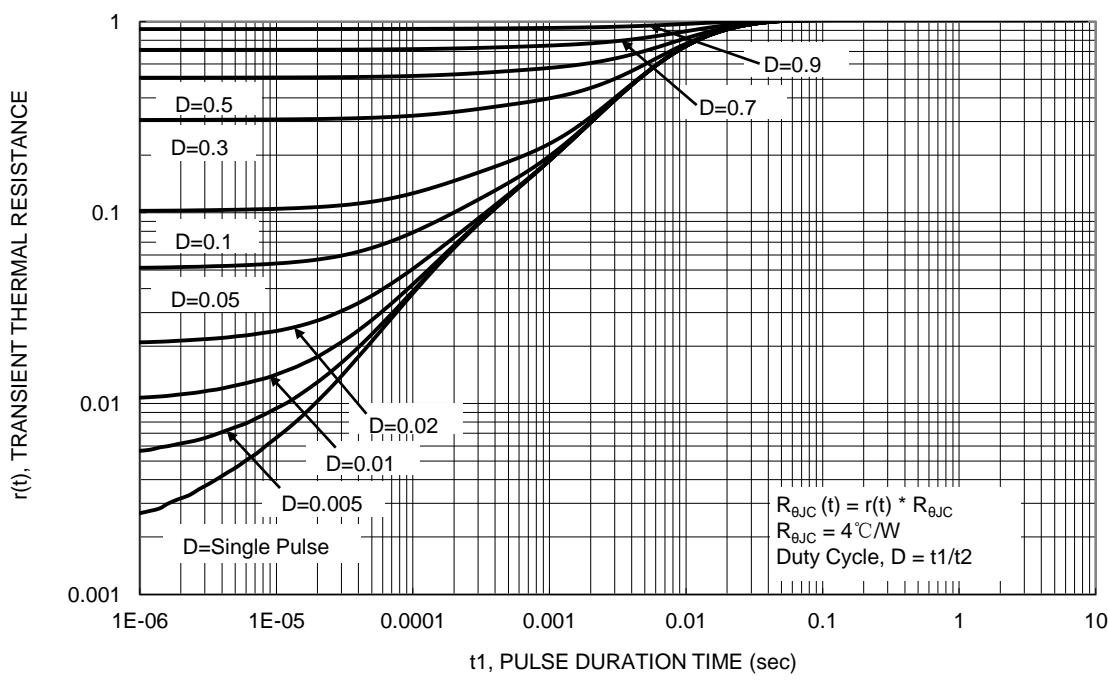
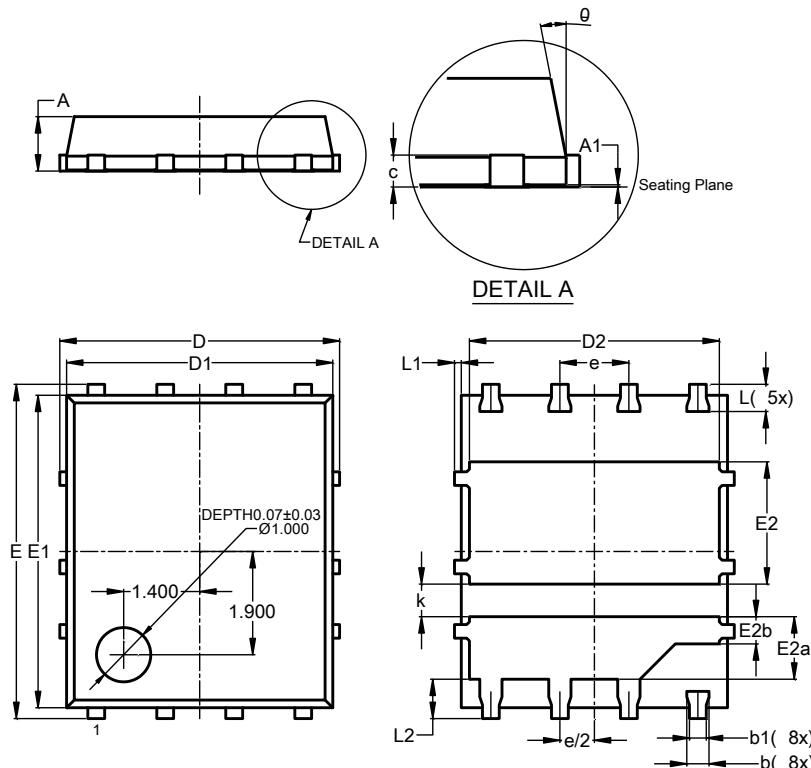


Figure 25. Transient Thermal Resistance

Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

PowerDI5060-8 (Type S)

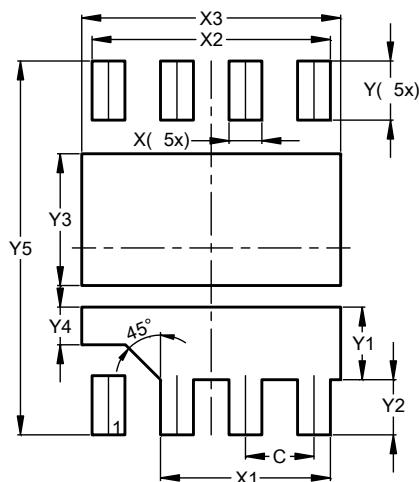


PowerDI5060-8 (Type S)			
Dim	Min	Max	Typ
A	0.90	1.10	1.00
A1	0.00	0.05	--
b	0.33	0.46	0.41
b1	0.23	0.36	0.31
c	0.230	0.330	0.254
D	--	--	5.15
D1	4.70	5.10	4.90
D2	4.50	4.70	4.60
E	--	--	6.15
E1	5.55	5.95	5.75
E2	2.15	2.35	2.25
E2a	1.05	1.25	1.15
E2b	0.45	0.55	0.50
e	1.27BSC		
k	0.50	0.70	0.60
L	0.40	0.60	0.50
L1	0.00	0.20	0.125
L2	0.625	0.825	0.725
θ	10°	12°	11°
All Dimensions in mm			

Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

PowerDI5060-8 (Type S)



Dimensions	Value (in mm)
C	1.270
X	0.610
X1	3.150
X2	4.420
X3	4.800
Y	1.100
Y1	1.350
Y2	1.025
Y3	2.450
Y4	0.700
Y5	6.950

IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

A. Life support devices or systems are devices or systems which:

1. are intended to implant into the body, or
2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2018, Diodes Incorporated

www.diodes.com